

Search Notes

Application/Control No.

10/787,015

Examiner

David M. Naff

Applicant(s)/Patent under
Reexamination

CHIN ET AL.

Art Unit

1651

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
<i>West</i> <i>Geo printant</i>	10/2/06	<i>en</i>